Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
10/585,143	KAMEISHI, KEIJI
Examiner	Art Unit
Stanban M. Cravini	2742

SEARCHED					
Class	Subclass	Date	Examiner		
34	60,90,201, 202,218	6/27/2009	SMG		
392	381	6/27/2009	SMG		
250	432R	6/27/2009	SMG		

INT	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		
		PT			
see search notes		6/27/2009	SMG		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
EAST US and foreign patent database searches including US pre-grant publication interference search (see IFW)	6/27/2009	SMG		